

TRANSFER REQUEST FOR

S.N. 08/909/189

TRANSFER REQUEST BY (PRINT NAME) Zarabian

Date 10-26-98

2785 Class/sub 377/211P

FROM: A.U. 2818 Class 365

Environmental Testing

Gatekeeper concurrence HEB for CJH

Hand carried: Personally accepted by _____

Section II a. DISPOSITION BY RECEIVING TC

By: LEE A.U. 2785 Date 11/10/98

☐ ACCEPTED BY RECEIVING T.C.

NOT ACCEPTED

☒ Forward to receiving TC Post Classifier

☐ Non-classification issue/other, return to Originating TC/AU _____

REASON:

*See U.S. Pat. # 3,751,526; 3,714,631; 4,992,951
for the sum of using memory read utilizing partially defective
memory chips. Class 365/200*

Section II b. DISPOSITION BY RECEIVING TC POST CLASSIFIER

☒ This dispute was resolved. Forward to TC/AU 2286 Class/Sub 364 or Post Classifier W. Fatahy Date 11/20/98

☐ This dispute was not resolved, forward to DISPUTE RESOLUTION PANEL
Post Classifier Assessment:

*Integrated circuit manufacturing and/or quality control for
determining defective IC chips is claimed.*

Gatekeeper Concurrence _____

Post Classifier _____

Date _____

Section III. DISPOSITION BY DISPUTE RESOLUTION PANEL

Date _____

Panel Decision: Forward to Technology Center / Art Unit _____

Class/sub _____

REASON: